

# Health Test Report

## For

**Applicant name:** Beijing Shulian Yunduan Technology Co., Ltd.  
**Address:** Room 128, 1st Floor, Building B, Courtyard 28, Xijiekouwai Avenue, Xicheng District, Beijing, China  
**EUT name:** True Wireless Earphones  
**Brand name:** FOR GLAM  
**Model number:** Pearl Clip  
**Series model number:** N/A  
**FCC ID:** 2BWKM-PEARLCLIP

## Issued By

**Company name:** BTF Testing Lab (Shenzhen) Co., Ltd.  
**Address:** Plant 101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, Guangdong, China  
**Report number:** BTF260617R00103  
**Test standards:** 47 CFR Part 2 Subpart J Section 2.1093  
**Test conclusion:** Pass  
**Date of sample receipt:** 2026-06-17  
**Test date:** 2026-06-18 to 2026-07-03  
**Date of issue:** 2026-07-04

**Prepared by:**

Vivi Yan

Vivi. Yan / Project engineer

**Approved by:**



Ryan.CJ / EMC manager

*Note: All the test results in this report only related to the testing samples. Which can be duplicated completely for the legal use with approval of applicant; it shall not be reproduced except in full without the written approval of BTF Testing Lab (Shenzhen) Co., Ltd.. All the objections should be raised within thirty days from the date of issue. To validate the report, you can contact us.*

| Revision History |            |                   |
|------------------|------------|-------------------|
| Version          | Issue date | Revisions content |
| R_V0             | 2026-07-04 | Original          |
|                  |            |                   |
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# 1 Introduction

## 1.1 Laboratory Location

|                |                                                                                                                                                                                                                                    |
|----------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Test location: | BTF Testing Lab (Shenzhen) Co., Ltd.                                                                                                                                                                                               |
| Address:       | Plant 101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, Guangdong, China                                                                                |
| Description:   | All measurement facilities used to collect the measurement data are located at Plant 101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, Guangdong, China |
| Phone number:  | +86-0755-23146130                                                                                                                                                                                                                  |
| Fax number:    | +86-0755-23146130                                                                                                                                                                                                                  |

## 1.2 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **FCC - Designation No.: CN1409**  
BTF Testing Lab (Shenzhen) Co., Ltd. has been accredited as a testing laboratory by FCC (Federal Communications Commission). The test firm Registration No. is 695374.
- **ISED – CAB identifier.: CN0135**  
The 3m Semi-anechoic chamber of BTF Testing Lab (Shenzhen) Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 27844.
- **CNAS - Registration No.: CNAS L17568**  
BTF Testing Lab (Shenzhen) Co., Ltd. is accredited to ISO/IEC 17025:2017 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L17568.
- **A2LA - Registration No.: 6660.01**  
BTF Testing Lab (Shenzhen) Co., Ltd. is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 General requirements for the competence of testing and calibration laboratories.

## 1.3 Announcement

- (1) The test report reference to the report template version v0.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.
- (5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- (6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.
- (7) All entrusted information in this report is provided by the client and has been confirmed through consultation with the client; The testing items for this report have been discussed and confirmed with the client, and our company is only responsible for the content reflected in the report.

## 2 Product Information

### 2.1 Application Information

|               |                                                                                                     |
|---------------|-----------------------------------------------------------------------------------------------------|
| Company name: | Beijing Shulian Yunduan Technology Co., Ltd.                                                        |
| Address:      | Room 128, 1st Floor, Building B, Courtyard 28, Xijiekouwai Avenue, Xicheng District, Beijing, China |

### 2.2 Manufacturer Information

|               |                                                                                                                                                                   |
|---------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Company name: | SHENZHEN SHI KISB ELECTRONIC CO., LTD.                                                                                                                            |
| Address:      | Room 301A, 4/F, Building A, Shanghe Industrial Park, Nanchang Road, Sanwei Community, Hangcheng Subdistrict, Bao'an District, Shenzhen, Guangdong Province, China |

### 2.3 Factory Information

|               |                                                                                                                                                                   |
|---------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Company name: | SHENZHEN SHI KISB ELECTRONIC CO., LTD.                                                                                                                            |
| Address:      | Room 301A, 4/F, Building A, Shanghe Industrial Park, Nanchang Road, Sanwei Community, Hangcheng Subdistrict, Bao'an District, Shenzhen, Guangdong Province, China |

### 2.4 General Description of Equipment under Test (EUT)

|                                           |                                                                                                                           |
|-------------------------------------------|---------------------------------------------------------------------------------------------------------------------------|
| EUT name                                  | True Wireless Earphones                                                                                                   |
| Under test model name                     | Pearl Clip                                                                                                                |
| Series model name                         | N/A                                                                                                                       |
| Description of model name differentiation | N/A                                                                                                                       |
| Hardware Version                          | V1                                                                                                                        |
| Software Version                          | V0.1                                                                                                                      |
| Rating:                                   | INPUT:5V=300mA<br>OUTPUT:5V=150mA(Max)<br>CAPACITY: 3.7V/300mAh/1.11Wh(Charging Station)<br>3.7V/45mAh/0.1665Wh(earphone) |

### 2.5 Technical Information

|                        |                                   |                            |
|------------------------|-----------------------------------|----------------------------|
| Modulation Mode:       | BT                                | GFSK, $\pi/4$ DQPSK, 8DPSK |
|                        | BLE                               | GFSK                       |
| Frequency Bands:       | BT                                | 2402MHz-2480MHz            |
|                        | BLE                               | 2402MHz-2480MHz            |
| Antenna type:          | FPC Antenna                       |                            |
| Antenna Gain:          | L: -0.25dBi                       |                            |
|                        | R: -2.23dBi(declare by Applicant) |                            |
| Antenna transmit mode: | SISO (1TX, 1RX)                   |                            |

### 3 RF Output Power

| Mode                  | Channel | Frequency (MHz) | Maximum Peak Conducted Output Power (dBm) |
|-----------------------|---------|-----------------|-------------------------------------------|
| BT-L                  | CH00    | 2402            | 3.12                                      |
| Maximum Tune-up (dBm) |         |                 | 4.00                                      |
| BT-R                  | CH00    | 2402            | 5.60                                      |
| Maximum Tune-up (dBm) |         |                 | 6.00                                      |
| BLE-L                 | CH00    | 2402            | 2.50                                      |
| Maximum Tune-up (dBm) |         |                 | 3.00                                      |
| BLE-R                 | CH00    | 2402            | 2.51                                      |
| Maximum Tune-up (dBm) |         |                 | 3.00                                      |

**Note 1:** According to KDB 447498, MPE assessment is based on source-based time-averaged maximum conducted output power of the RF channel requiring assessment, adjusted for tune-up tolerance, and the minimum test separation distance required for the exposure conditions.

## 4 Applied Reference Documents

| Identity              | Document Title                                                  |
|-----------------------|-----------------------------------------------------------------|
| 47 CFR Part 2(2.1093) | Radio Frequency Radiation Exposure Assessment: Portable Devices |
| KDB 447498 D01v06     | General RF Exposure Guidance                                    |

## 5 RF Exposure Limit

|                 |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                |
|-----------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Test Standards: | KDB447498 D01 General RF Exposure Guidance v06: Rf Exposure Procedures And Equipment Authorization Policies For Mobile And Portable Devices                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    |
| Test Limit:     | <p>For 100 MHz to 6 GHz and test separation distances <math>\leq 50</math> mm, the 1-g and 10-g SAR test exclusion thresholds are determined by the following:</p> $[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [\sqrt{f_{\text{GHz}}}] \leq 3.0 \text{ for 1-g SAR, and } \leq 7.5 \text{ for 10-g extremity SAR,}^{30} \text{ where}$ <p><sup>30</sup> This is equivalent to the formula written as: <math>[(\text{max. power of channel, including tune-up tolerance, mW}) / (60 / \sqrt{f_{\text{GHz}}})] \cdot [20 \text{ mm} / (\text{min. test separation distance, mm})] \leq 1.0</math> for 1-g SAR; also see Appendix A for approximate exclusion threshold numerical values at selected frequencies and distances.</p> <p><math>f_{\text{GHz}}</math> is the RF channel transmit frequency in GHz.<br/> Power and distance are rounded to the nearest mW and mm before calculation.<br/> The result is rounded to one decimal place for comparison.<br/> 3.0 Where is the exposure limit for the head assessment.<br/> 7.5 Where is the exposure limit for assessing the effects on the limbs.</p> <p><b>Remark:</b> The test exclusions are applicable only when the minimum test separation distance is <math>\leq 50</math> mm, and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is <math>&lt; 5</math> mm, a distance of 5 mm according to 4.1 f) is applied to determine SAR test exclusion.</p> |

## 6 RF Exposure Assessment

### ➤ Standalone Transmission Assessment:

| Bands | Frequency (MHz) | Max Conducted Power (dBm) | Tune-up Power(dBm) | Tune-up Power(mW) | Calculating data | Limit |
|-------|-----------------|---------------------------|--------------------|-------------------|------------------|-------|
| BT-L  | 2402            | 3.12                      | 4.0                | 2.51              | 0.78             | 3.0   |
| BT-R  | 2402            | 5.60                      | 6.0                | 3.98              | 1.23             | 3.0   |
| BLE-L | 2402            | 2.50                      | 3.0                | 2.00              | 0.62             | 3.0   |
| BLE-R | 2402            | 2.51                      | 3.0                | 2.00              | 0.62             | 3.0   |

### ➤ Conclusion:

According to 47 CFR §2.1093, this device complies with human exposure basic restrictions.



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**--END OF REPORT--**